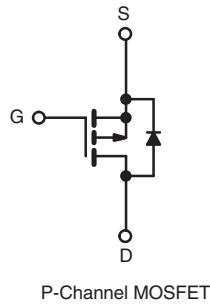
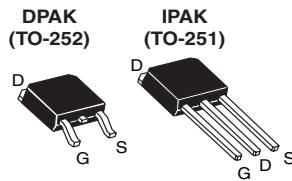


## Power MOSFET

| PRODUCT SUMMARY           |                   |      |
|---------------------------|-------------------|------|
| $V_{DS}$ (V)              | - 50              |      |
| $R_{DS(on)}$ ( $\Omega$ ) | $V_{GS} = - 10$ V | 0.28 |
| $Q_g$ (Max.) (nC)         | 14                |      |
| $Q_{gs}$ (nC)             | 6.5               |      |
| $Q_{gd}$ (nC)             | 6.5               |      |
| Configuration             | Single            |      |



### FEATURES

- Surface Mountable (Order As IRFR9020, SiHFR9020)
- Straight Lead Option (Order As IRFU9020, SiHFU9020)
- Repetitive Avalanche Ratings
- Dynamic  $dV/dt$  Rating
- Simple Drive Requirements
- Ease of Paralleling
- Lead (Pb)-free Available



### DESCRIPTION

The Power MOSFET technology is the key to Vishay's advanced line of Power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery  $dV/dt$ .

The Power MOSFET transistors also feature all of the well established advantages of MOSFET'S such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

Surface mount packages enhance circuit performance by reducing stray inductances and capacitance. The TO-252 surface mount package brings the advantages of Power MOSFET's to high volume applications where PC Board surface mounting is desirable. The surface mount option IRFR9020, SiHFR9020 is provided on 16mm tape. The straight lead option IRFU9020, SiHFU9020 of the device is called the IPAK (TO-251).

They are well suited for applications where limited heat dissipation is required such as, computers and peripherals, telecommunication equipment, DC/DC converters, and a wide range of consumer products.

| ORDERING INFORMATION |               |                            |                             |               |
|----------------------|---------------|----------------------------|-----------------------------|---------------|
| Package              | DPAK (TO-252) | DPAK (TO-252)              | DPAK (TO-252)               | IPAK (TO-251) |
| Lead (Pb)-free       | IRFR9020PbF   | IRFR9020TRPbF <sup>a</sup> | IRFR9020TRLPbF <sup>a</sup> | IRFU9020PbF   |
|                      | SiHFR9020-E3  | SiHFR9020T-E3 <sup>a</sup> | SiHFR9020TL-E3 <sup>a</sup> | SiHFU9020-E3  |
| SnPb                 | IRFR9020      | IRFR9020TR <sup>a</sup>    | IRFR9020TRL <sup>a</sup>    | IRFU9020      |
|                      | SiHFR9020     | SiHFR9020T <sup>a</sup>    | SiHFR9020TL <sup>a</sup>    | SiHFU9020     |

#### Note

a. See device orientation.

| ABSOLUTE MAXIMUM RATINGS $T_C = 25^\circ\text{C}$ , unless otherwise noted |                    |                           |          |                     |
|--|--------------------|---------------------------|----------|---------------------|
| PARAMETER  | SYMBOL             |                           | LIMIT    | UNIT                |
| Drain-Source Voltage   | $V_{DS}$           |                           | - 50     | V                   |
| Gate-Source Voltage  | $V_{GS}$           |                           | $\pm 20$ |                     |
| Continuous Drain Current   | $V_{GS}$ at - 10 V | $T_C = 25^\circ\text{C}$  | - 9.9    | A                   |
|  |                    | $T_C = 100^\circ\text{C}$ | - 6.3    |                     |
| Pulsed Drain Current <sup>a</sup>  | $I_{DM}$           |                           | - 40     |                     |
| Linear Derating Factor   |                    |                           | 0.33     | W/ $^\circ\text{C}$ |
| Single Pulse Avalanche Energy <sup>b</sup>                                 | $E_{AS}$           |                           | 440      | mJ                  |
| Repetitive Avalanche Current <sup>a</sup>                                  | $I_{AR}$           |                           | - 9.9    | A                   |
| Repetitive Avalanche Energy <sup>a</sup>                                   | $E_{AR}$           |                           | 4.2      | mJ                  |

\* Pb containing terminations are not RoHS compliant, exemptions may apply

| <b>ABSOLUTE MAXIMUM RATINGS</b> $T_C = 25\text{ }^\circ\text{C}$ , unless otherwise noted |                                  |                |                  |                  |
|---|----------------------------------|----------------|------------------|------------------|
| PARAMETER   |                                  | SYMBOL         | LIMIT            | UNIT             |
| Maximum Power Dissipation   | $T_C = 25\text{ }^\circ\text{C}$ | $P_D$          | 42               | W                |
| Peak Diode Recovery $dV/dt^c$   |                                  | $dV/dt$        | 5.8              | V/ns             |
| Operating Junction and Storage Temperature Range  |                                  | $T_J, T_{stg}$ | - 55 to + 150    | $^\circ\text{C}$ |
| Soldering Recommendations (Peak Temperature)  | for 10 s                         |                | 300 <sup>d</sup> |                  |


### Notes

- Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- $V_{DD} = -25\text{ V}$ , Starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $L = 5.1\text{ mH}$ ,  $R_G = 25\text{ }\Omega$ , Peak  $I_L = -9.9\text{ A}$
- $I_{SD} \leq -9.9\text{ A}$ ,  $dI/dt \leq -120\text{ A}/\mu\text{s}$ ,  $V_{DD} \leq 40\text{ V}$ ,  $T_J \leq 150\text{ }^\circ\text{C}$ .
- 0.063" (1.6 mm) from case.
- When mounted on 1" square PCB (FR-4 or G-10 material).

| <b>THERMAL RESISTANCE RATINGS</b> |            |      |      |      |                           |
|-----------------------------------|------------|------|------|------|---------------------------|
| PARAMETER                         | SYMBOL     | MIN. | TYP. | MAX. | UNIT                      |
| Maximum Junction-to-Ambient       | $R_{thJA}$ | -    | -    | 110  | $^\circ\text{C}/\text{W}$ |
| Case-to-Sink                      | $R_{thCS}$ | -    | 1.7  | -    |                           |
| Maximum Junction-to-Case (Drain)  | $R_{thJC}$ | -    | -    | 3.0  |                           |

| <b>SPECIFICATIONS</b> $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted |              |  |   |  |       |      |           |               |
|---|--------------|--|---|--|-------|------|-----------|---------------|
| PARAMETER   | SYMBOL       | TEST CONDITIONS  |   |  | MIN.  | TYP. | MAX.      | UNIT          |
| <b>Static</b>   |              |  |   |  |       |      |           |               |
| Drain-Source Breakdown Voltage  | $V_{DS}$     | $V_{GS} = 0\text{ V}$ , $I_D = -250\text{ }\mu\text{A}$  |   |  | - 50  | -    | -         | V             |
| Gate-Source Threshold Voltage   | $V_{GS(th)}$ | $V_{DS} = V_{GS}$ , $I_D = -250\text{ }\mu\text{A}$  |   |  | - 2.0 | -    | - 4.0     | V             |
| Gate-Source Leakage   | $I_{GSS}$    | $V_{GS} = \pm 20\text{ V}$   |   |  | -     | -    | $\pm 500$ | nA            |
| Zero Gate Voltage Drain Current   | $I_{DSS}$    | $V_{DS} = \text{max. rating}$ , $V_{GS} = 0\text{ V}$  |   |  | -     | -    | 250       | $\mu\text{A}$ |
|   |              | $V_{DS} = 0.8 \times \text{max. rating}$ , $V_{GS} = 0\text{ V}$ , $T_J = 125\text{ }^\circ\text{C}$   |   |  | -     | -    | 1000      |               |
| Drain-Source On-State Resistance  | $R_{DS(on)}$ | $V_{GS} = -10\text{ V}$  | $I_D = 5.7\text{ A}^b$  |  | -     | 0.20 | 0.28      | $\Omega$      |
| Forward Transconductance  | $g_{fs}$     | $V_{DS} \leq -50\text{ V}$ , $I_{DS} = -5.7\text{ A}$  |   |  | 2.3   | 3.5  | -         | S             |
| <b>Dynamic</b>  |              |  |   |  |       |      |           |               |
| Input Capacitance   | $C_{iss}$    | $V_{GS} = 0\text{ V}$ ,<br>$V_{DS} = -25\text{ V}$ ,<br>$f = 1.0\text{ MHz}$ , see fig. 9  |   |  | -     | 490  | -         | pF            |
| Output Capacitance  | $C_{oss}$    |  |   |  | -     | 320  | -         |               |
| Reverse Transfer Capacitance  | $C_{rss}$    |  |   |  | -     | 70   | -         |               |
| Total Gate Charge   | $Q_g$        | $V_{GS} = -10\text{ V}$  | $I_D = -9.7\text{ A}$ , $V_{DS} = 0.8 \times \text{max. rating}$ , see fig. 16<br>(Independent operating temperature) |  | -     | 9.4  | 14        | nC            |
| Gate-Source Charge  | $Q_{gs}$     |  |   |  | -     | 4.3  | 6.5       |               |
| Gate-Drain Charge   | $Q_{gd}$     |  |   |  | -     | 4.3  | 6.5       |               |
| Turn-On Delay Time  | $t_{d(on)}$  | $V_{DD} = -25\text{ V}$ , $I_D = -9.7\text{ A}$ ,<br>$R_G = 18\text{ }\Omega$ , $R_D = 2.4\text{ }\Omega$ , see fig. 15<br>(Independent operating temperature) |   |  | -     | 8.2  | 12        | ns            |
| Rise Time   | $t_r$        |  |   |  | -     | 57   | 66        |               |
| Turn-Off Delay Time   | $t_{d(off)}$ |  |   |  | -     | 12   | 18        |               |
| Fall Time   | $t_f$        |  |   |  | -     | 25   | 38        |               |
| Internal Drain Inductance   | $L_D$        | Between lead,<br>6 mm (0.25") from<br>package and center of<br>die contact.  |   |  | -     | 4.5  | -         | nH            |
| Internal Source Inductance  | $L_S$        |  |   |  | -     | 7.5  | -         |               |



| SPECIFICATIONS $T_J = 25^\circ\text{C}$ , unless otherwise noted |          |   |      |      |       |      |
|--|----------|---|------|------|-------|------|
| PARAMETER  | SYMBOL   | TEST CONDITIONS   | MIN. | TYP. | MAX.  | UNIT |
| <b>Drain-Source Body Diode Characteristics</b>                   |          |   |      |      |       |      |
| Continuous Source-Drain Diode Current                            | $I_S$    | MOSFET symbol showing the integral reverse p-n junction diode  | -    | -    | - 9.9 | A    |
| Pulsed Diode Forward Current <sup>a</sup>                        | $I_{SM}$ |   | -    | -    | - 40  |      |
| Body Diode Voltage   | $V_{SD}$ | $T_J = 25^\circ\text{C}$ , $I_S = -9.9\text{ A}$ , $V_{GS} = 0\text{ V}^b$  | -    | -    | - 6.3 | V    |
| Body Diode Reverse Recovery Time                                 | $t_{rr}$ | $T_J = 25^\circ\text{C}$ , $I_F = -9.7\text{ A}$ , $dI/dt = 100\text{ A}/\mu\text{s}^b$   | 56   | 110  | 280   | ns   |
| Body Diode Reverse Recovery Charge                               | $Q_{rr}$ |   | 0.17 | 0.34 | 0.85  | nC   |
| Forward Turn-On Time   | $t_{on}$ | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )   |      |      |       |      |

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 14).
- b. Pulse width  $\leq 300\ \mu\text{s}$ ; duty cycle  $\leq 2\%$ .

**TYPICAL CHARACTERISTICS**  $25^\circ\text{C}$ , unless otherwise noted

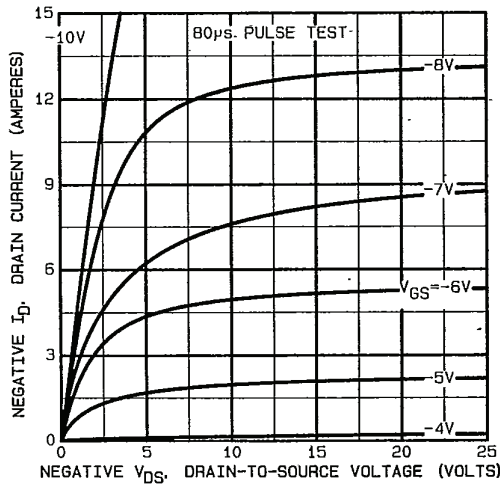


Fig. 1 - Typical Output Characteristics

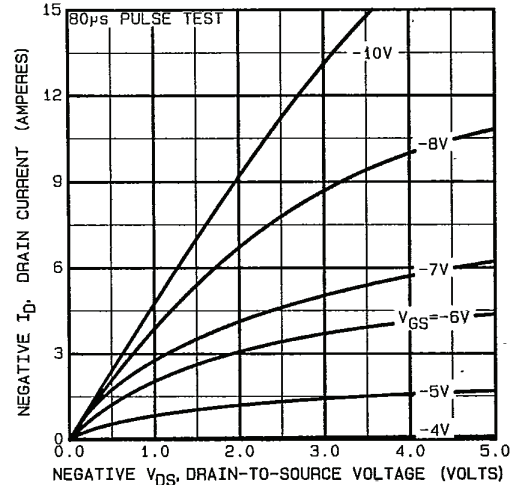


Fig. 3 - Typical Saturation Characteristics

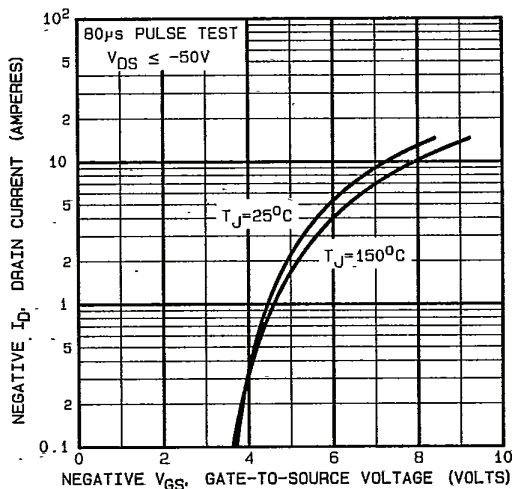


Fig. 2 - Typical Transfer Characteristics

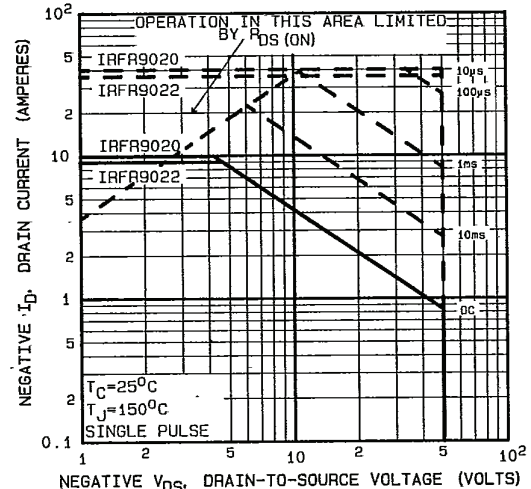


Fig. 4 - Maximum Safe Operating Area

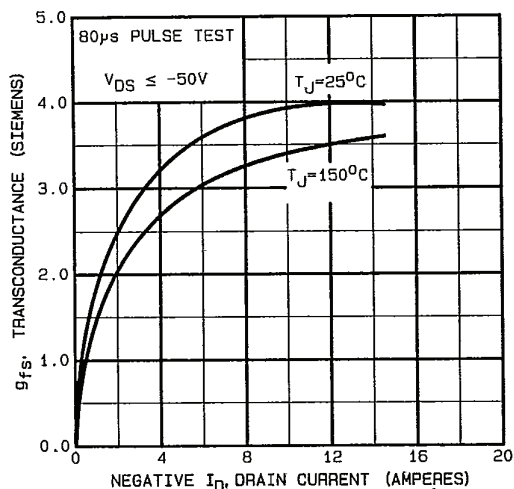


Fig. 5 - Typical Transconductance vs. Drain Current

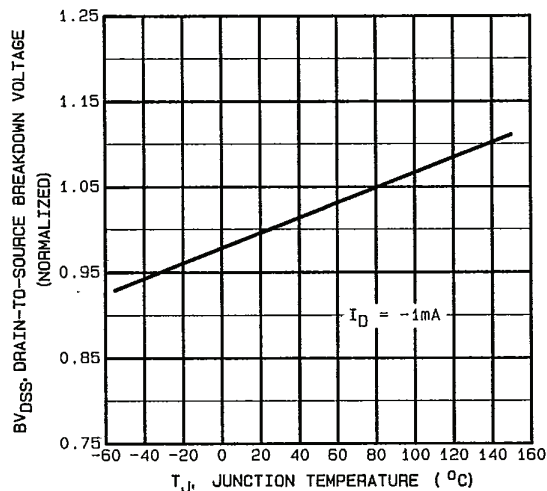


Fig. 7 - Breakdown Voltage vs. Temperature

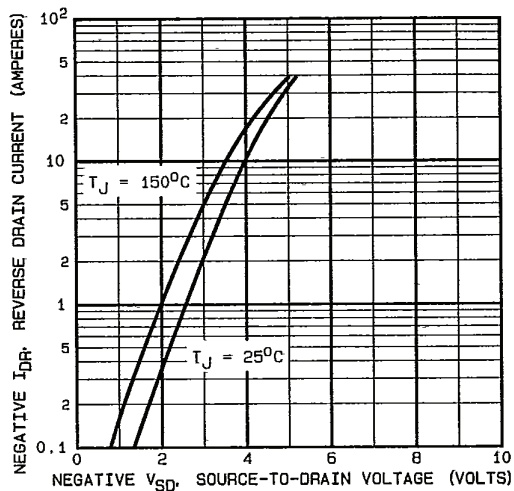


Fig. 6 - Typical Source-Drain Diode Forward Voltage

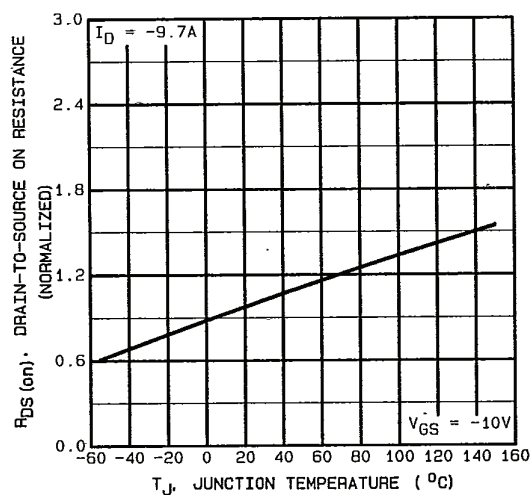


Fig. 8 - Normalized On-Resistance vs. Temperature

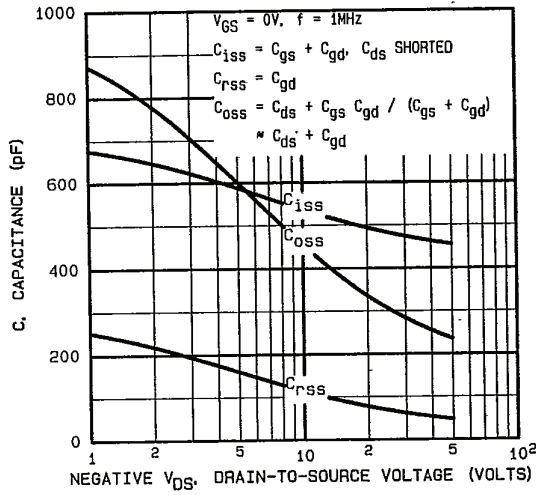


Fig. 9 - Typical Capacitance vs. Drain-to-Source Voltage

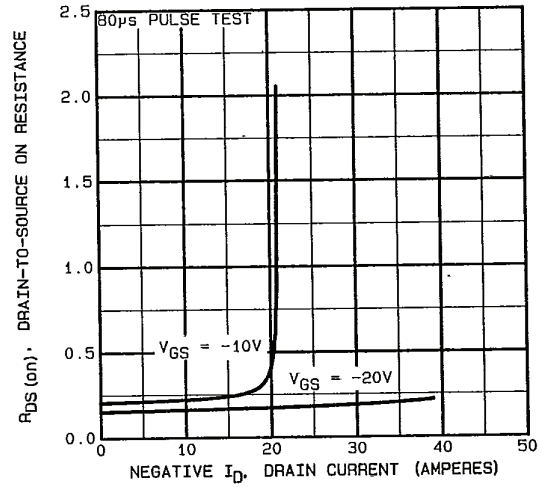


Fig. 11 - Typical On-Resistance vs. Drain Current

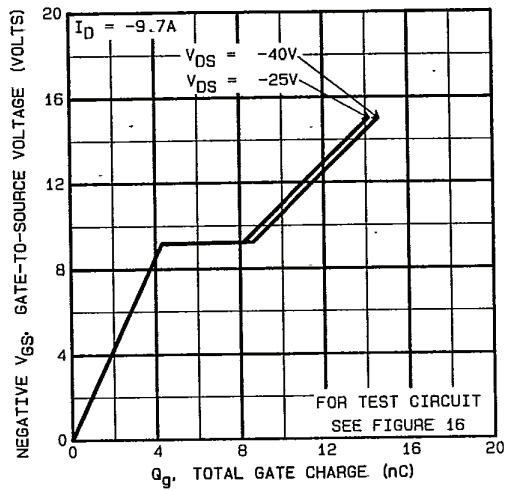


Fig. 10 - Typical Gate Charge vs. Gate-to-Source Voltage

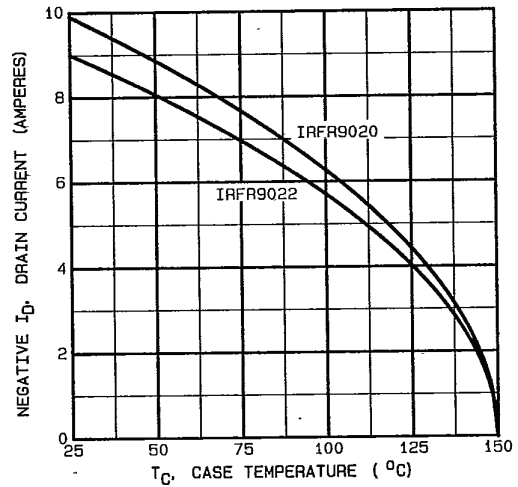


Fig. 12 - Maximum Drain Current vs. Case Temperature

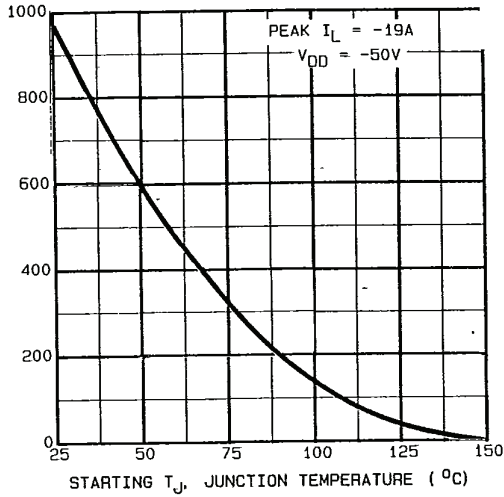


Fig. 13a - Maximum Avalanche vs. Starting Junction Temperature

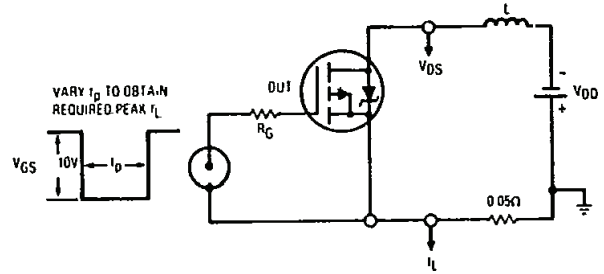


Fig. 13b - Unclamped Inductive Test Circuit

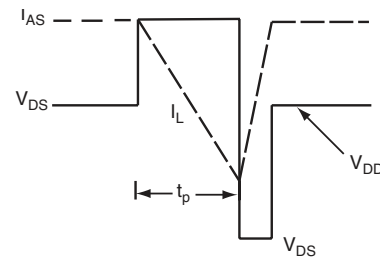


Fig. 13c - Unclamped Inductive Waveforms

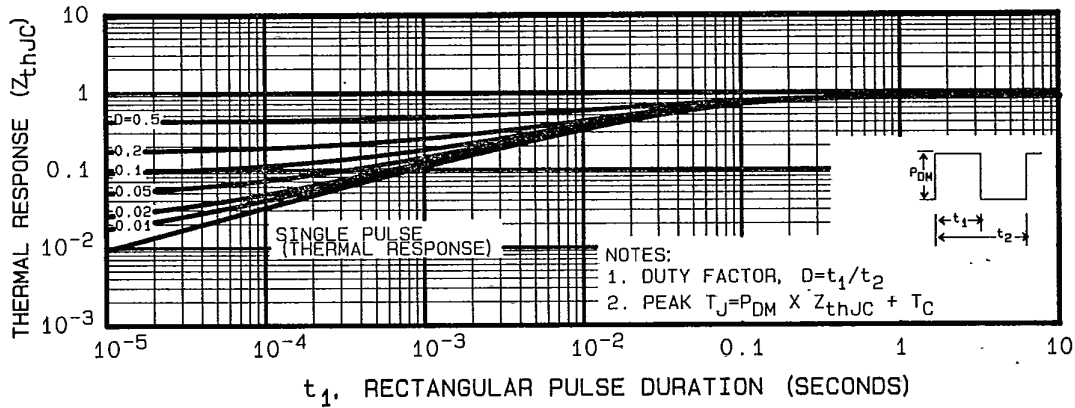


Fig. 14 - Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

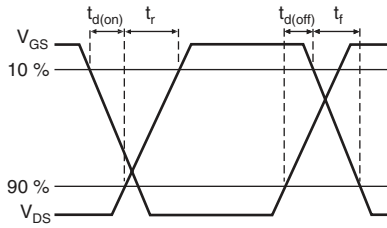


Fig. 15a - Switching Time Waveforms

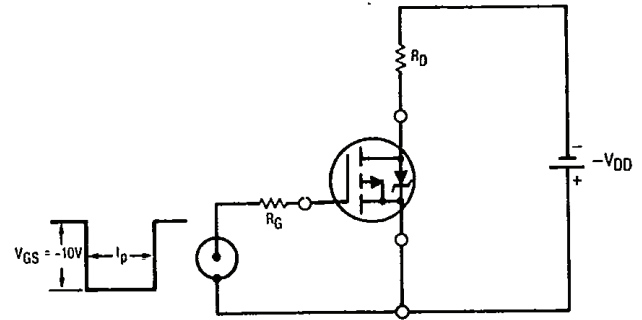


Fig. 15b - Switching Time Test Circuit

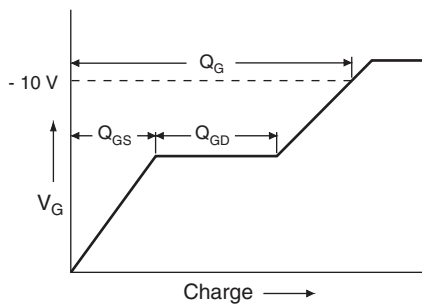


Fig. 16a - Basic Gate Charge Waveform

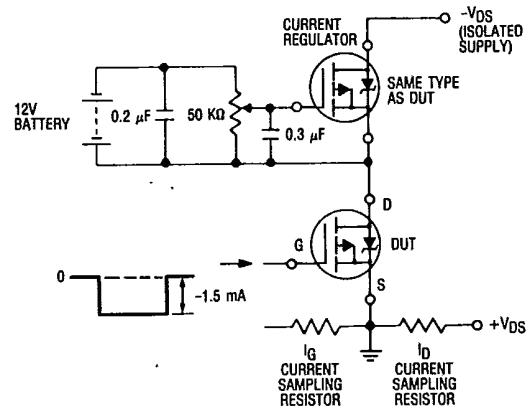
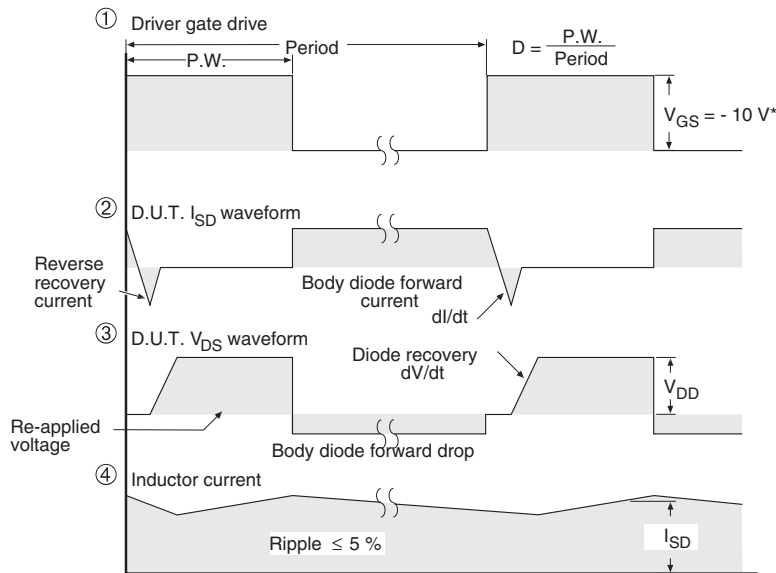
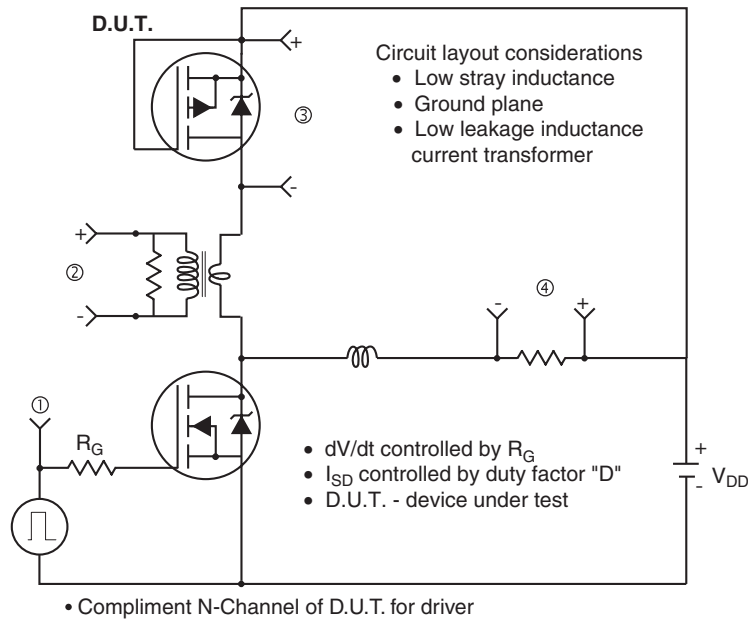


Fig. 16b - Gate Charge Test Circuit

## Peak Diode Recovery dV/dt Test Circuit



\*  $V_{GS} = -5\text{ V}$  for logic level and  $-3\text{ V}$  drive devices

**Fig. 17 - For P-Channel**

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